

Search Notes

Application/Control No.

10/823,613

Examiner

Hieu P. Nguyen

Applicant(s)/Patent under
Reexamination

WILES ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	308	12/19/2005	HN
330	86	12/19/2005	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
U.S-PGPUB.		12/19/2005	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST UPDATE SEARCH	12/19/2005	HN